

X-ray Stacking

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Motivation for stacking

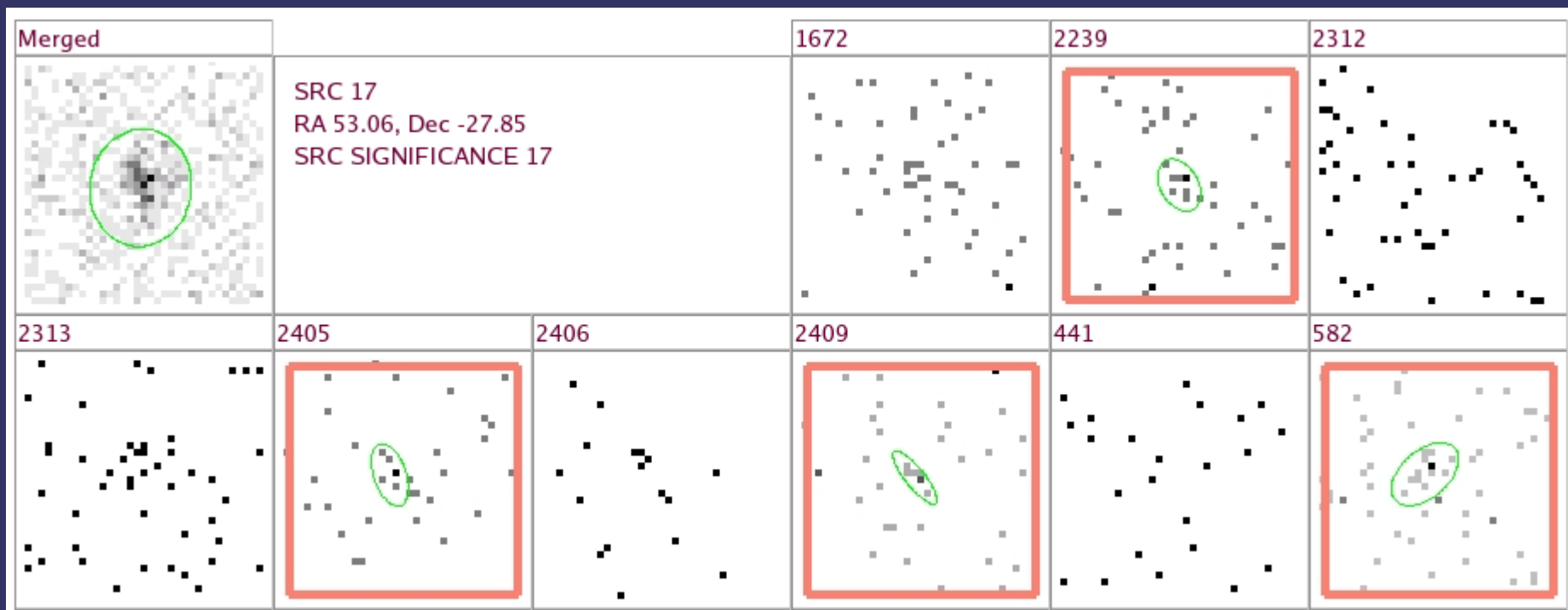
- ➔ Multiwavelength analysis is a major theme in modern astrophysics
- ➔ Many types of astrophysical sources emit (at some level) over a wide range spanning radio to gamma rays
- ➔ Detection efficiency of a source class (e.g. obscured active galactic nuclei) is often best in a particular band
- ➔ Observations in other bands may result in non-detections
- ➔ How can we get the most information from the non-detections?
 - Individual SEDs – upper limits constrain physical models
 - Survival analysis for a sample
 - Stacking – mean properties of sample
- ➔ Chandra X-ray data (faint point sources) are photon-limited with low background => **stacking in X-rays is very effective**

Stacking basics: Make an image

- ➔ Define source positions from input catalog

EXAMPLES:

- 1376 (2308) optically-selected unobscured QSOs from SDSS
 - ~1600 (2150) IR-selected sources from Spitzer (obscured AGN)
- ➔ Extract image cutouts in X-ray data at each source position
 - ➔ Co-add images for sources that are *not detected* in X-ray

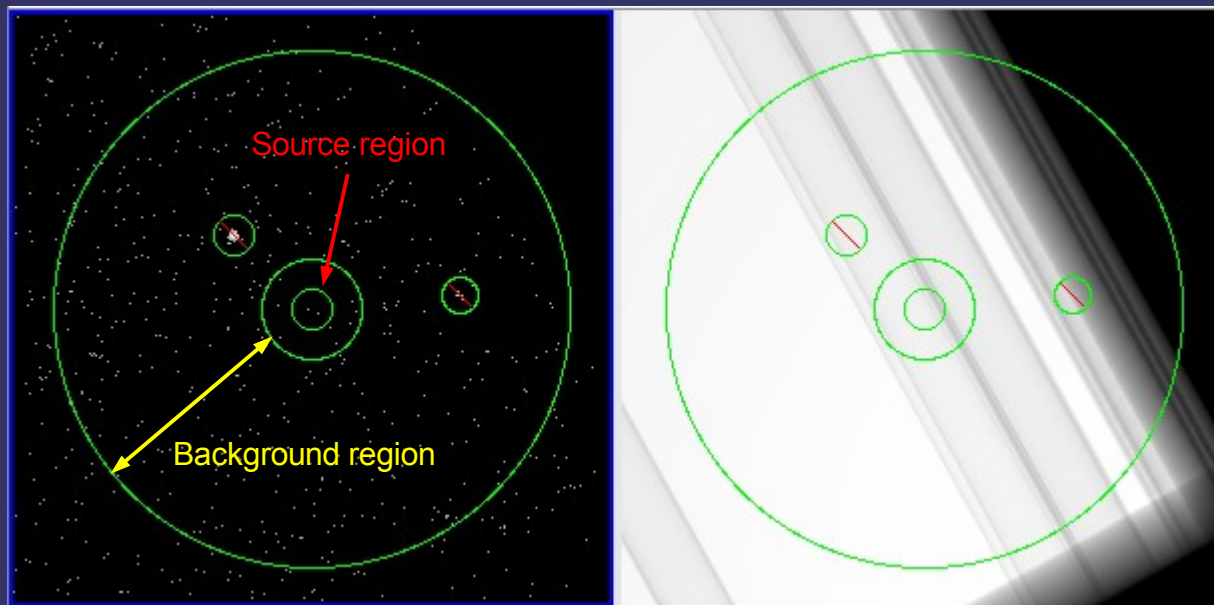


Source, background and exposure map

- ⇒ At the position of source i in input catalog define source region S_i based on local PSF and background region B_i
- ⇒ Exclude sources that are known from X-ray or input catalogs
- ⇒ Exposure map $E_{S,i}$ is effective area (cm^2) \times exposure time (sec) at each pixel

X-ray photons for source i

Exposure map



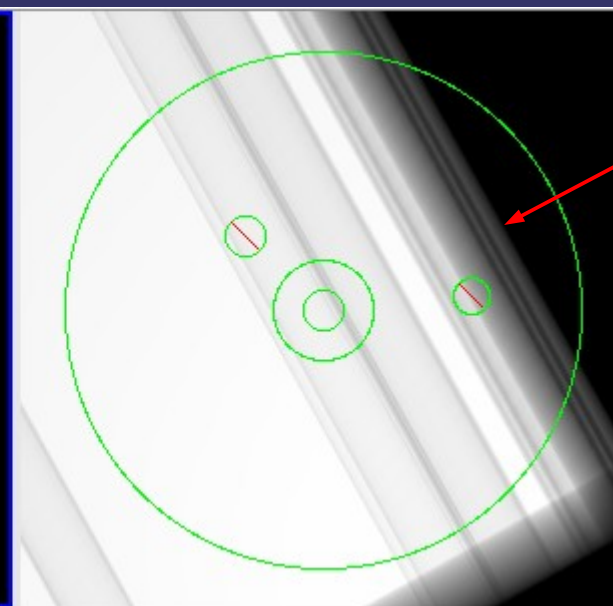
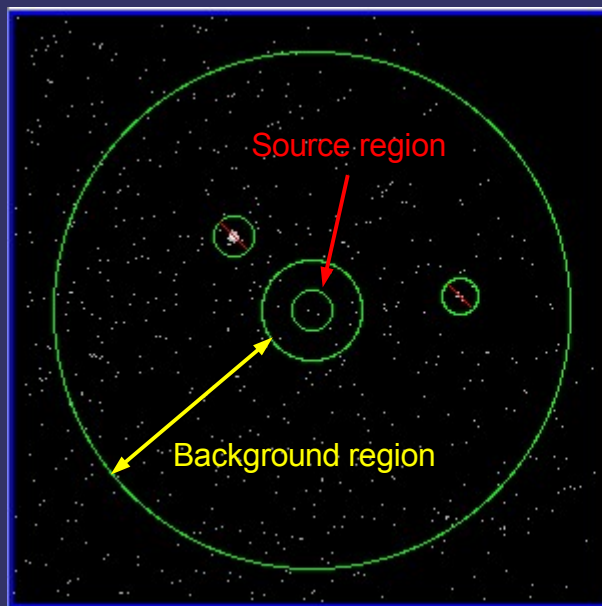
Stacking basics: Net counts and flux

- ➔ Net counts C and mean flux f

$$C = \sum_i \left(S_i - B_i \frac{\sum_{pix} E_{S,i}}{\sum_{pix} E_{B,i}} \right) \quad \bar{f} = \frac{C}{\sum_i \bar{E}_{S,i}}$$

X-ray photons for source i

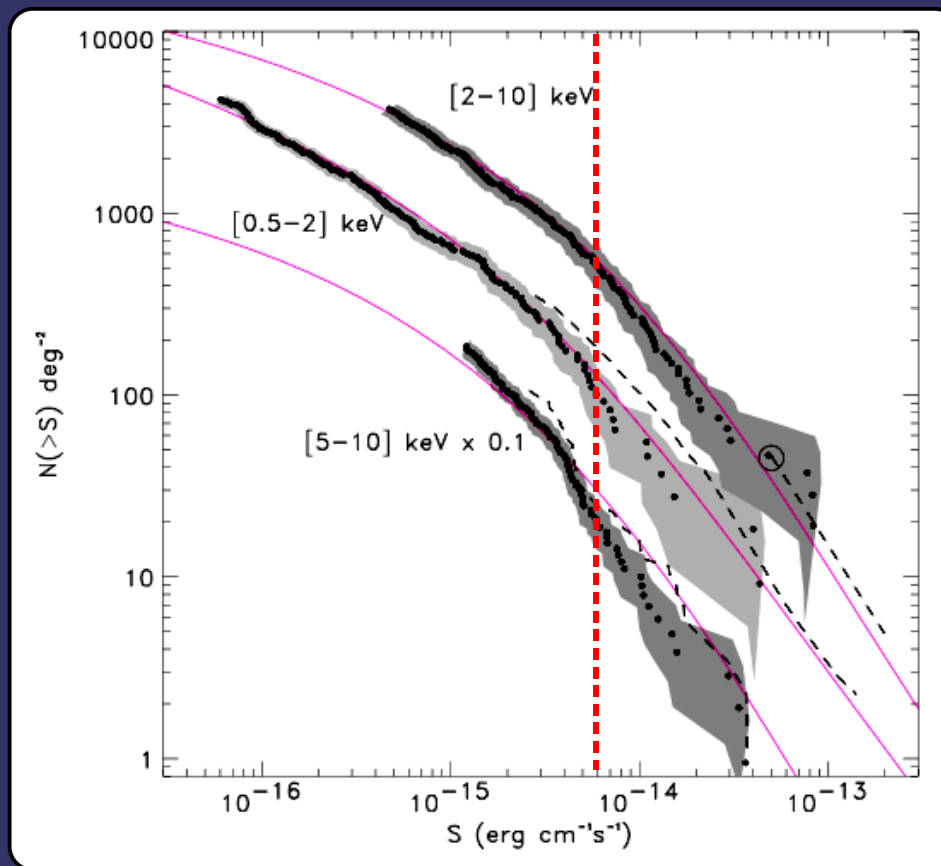
Exposure map



Edge of detector

Issues

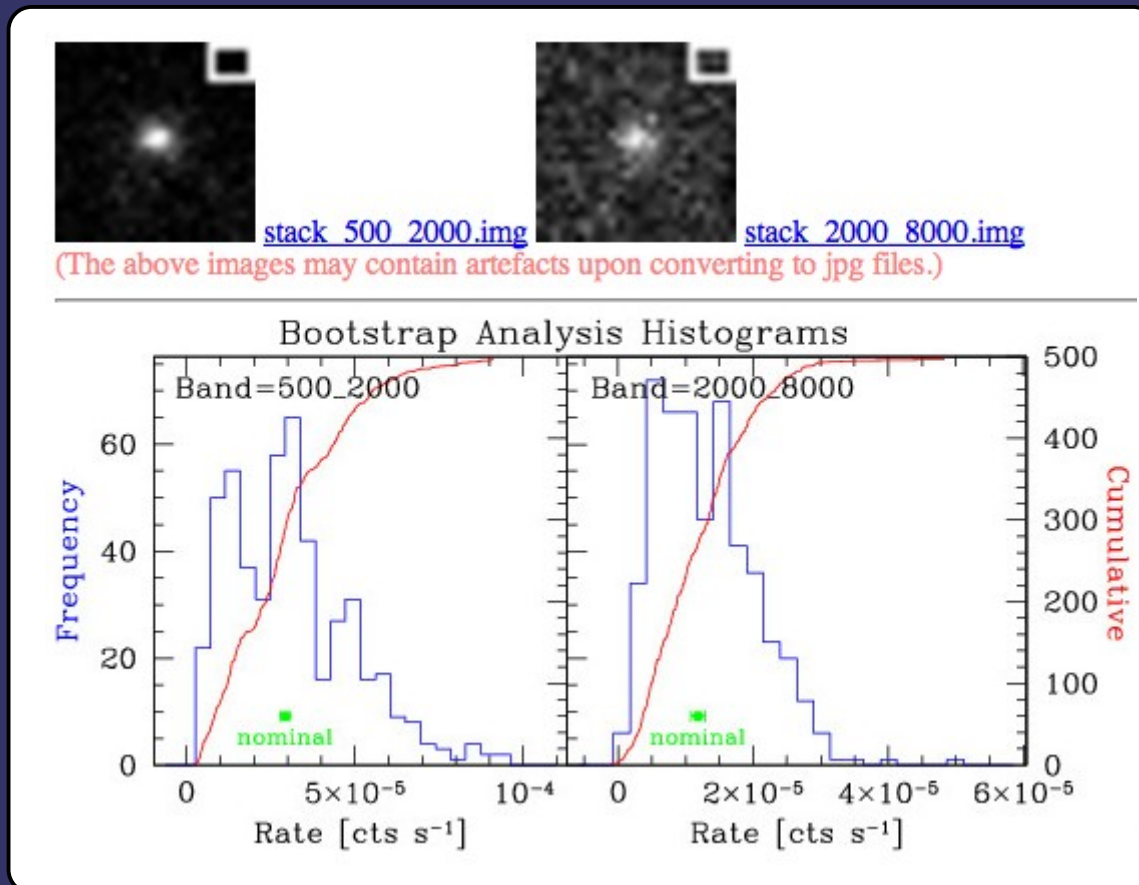
- ➔ The sample of X-ray “non-detections” depends on detect method and draws a hard distinction between sources straddling the detection limit
- ➔ Are a few sources dominating the signal?



Rosati et al. ApJS 139 (2002)

Issues

- ➔ Estimate distribution in N or f by random resampling of input sources
- ➔ Question – what is this really telling us?



<http://saturn.phys.cmu.edu/cstack>
User: guest Password: guest

Advanced stacking: ChaMP + SDSS

- ➔ Simple stacking tools calculate net counts or flux assuming homogeneous data sets - exposure and responses are fairly uniform.
- ➔ The Chandra Multiwavelength Project (ChaMP) is a very large X-ray survey using archival data spanning 6 years: GOOD
- ➔ The ChaMP has with a wide range in exposure and responses: BAD
- ➔ The goal is to properly account for these complications to explore AGN and galaxy physics and evolution.
- ➔ The Sloan Digital Sky Survey (SDSS) is a massive optical survey of the sky which provides > 100,000 spectroscopically confirmed quasars with redshifts (and much much more).
- ➔ There is a 30 deg² overlap between ChaMP and SDSS.

Advanced stacking: Luminosity for a heterogenous sample

- ➔ Since we have redshift (distance) estimates for the input SDSS samples we want to infer luminosity rather than flux.

		<i>Dependencies</i>	<i>Units</i>
$L(\mathcal{E}_{\text{rest}}) =$	$C(\mathcal{E}_{\text{obs}})$		counts
	$\times \text{ApertureCorrection}$	(Position)	counts
	$\times \text{ExposureMap}^{-1}$	(Time, position, detector, etc)	photons/cm ² /sec
	$\times \text{EnergyCorrectionFactor}$	(\mathcal{E}_{obs} , spectrum, z)	erg/cm ² /sec
	$\times (4\pi d_l^2)^{-1}$	(z, cosmology)	erg/sec [$\mathcal{E}_{\text{obs}}/(1+z)$]
	$\times \text{Kcorrection}$	(z, \mathcal{E}_{obs} , $\mathcal{E}_{\text{rest}}$, spectrum)	erg/sec

$$\bar{L} = \frac{1}{N} \sum_i C_i \frac{A_{\text{corr},i} \times \text{ECF}_i \times K_{\text{corr},i}}{\bar{E}_{S,i} 4\pi d_{l,i}^2}$$

Mean of L values

$$\bar{L} = \frac{1}{\sum_i \bar{E}_{S,i}} \sum_i C_i \frac{A_{\text{corr},i} \times \text{ECF}_i \times K_{\text{corr},i}}{4\pi d_{l,i}^2}$$

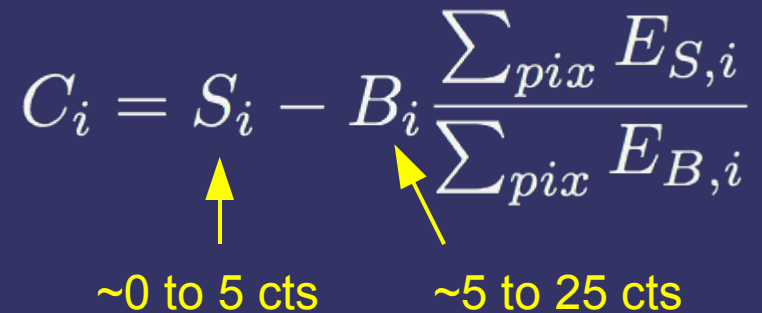
Weight by exposure as per flux calculation

Is this even "stacking" any more?

Discussion!

- ➔ Now the real question: Some mean luminosity will be generated but how do we calculate the confidence intervals?

$$C_i = S_i - B_i \frac{\sum_{pix} E_{S,i}}{\sum_{pix} E_{B,i}}$$



~0 to 5 cts ~5 to 25 cts

$$\bar{L} = \frac{1}{\sum_i \bar{E}_{S,i}} \sum_i C_i \frac{A_{\text{corr},i} \times \text{ECF}_i \times K_{\text{corr},i}}{4\pi d_{l,i}^2}$$

- ➔ Would it be useful to plot / analyze histograms of L_i ? This avoids the (somewhat) arbitrary distinction between detected and non-detected sources.